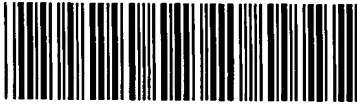


Search Notes

Application/Control No.

10/541,347

Examiner

Patrick T. Lewis

Applicant(s)/Patent under
Reexamination

ECKL ET AL.

Art Unit

1623

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Structure and Inventor search by STIC (Suppl. Content)	10/26/2007	PL